E080090	-B-	D
Drawing No	Rev.	Group
Sheet 1	of	2

ETM Penultimate Mass

1 Applicable Documents

This document supports the drawing:

D080117_ALIGO_SUS_ETM QUAD Penultimate Mass - B

2 Requirements

Material

Fused Silica (choose from following list)

- Heraeus Suprasil (any grade, including commercial grades)
- Heraeus HOO 310
- Schott Lithosil QT
- Corning 7980 5G
- Corning 7980 Substrate Grade

NOTE: Material to be supplied with a certificate of conformity

Physical configuration

Shape and polish according to:

D080117 ALIGO SUS ETM QUAD Penultimate Mass

Reference Markings:

Registration Marks shall be etched, ground or sandblasted, and located per LIGO-D080117.

Serial Number:

The Serial number shall be etched, ground or sandblasted, and located per LIGO-D080117.

3 Inspection

Specification	Manufacturing note / drawing zone (LIGO-D080117)	Test Method	Data delivered
Outside diameter	(Zone E10)	Physical inspection	Measurement at six equally spaced locations, plus mean measurement
Thickness	(Zone F6)	Physical inspection	Measurement at six locations (equally spaced around barrel, starting at location of arrow pointing at surface 'S1'), plus mean measurement
Flat length (surface S3)	(Zone D11)	٠.	Measured dimension (sharp to sharp)
Flat length (surface S4)	(Zone D8)	cc	Measured dimension (sharp to sharp)
Flat to Flat separation (at central location)	(Zone C9)	cc	Measured dimension
Edges and chamfers	Note 3	Visual inspection	Inspection report included with certification
Scratches and point defects	Note 3	Visual inspection	Inspection report included with certification

LASER INTERFEROMETER GRAVITATIONAL WAVE OBSERVATORY ŁIGO

COMPONENT SPECIFICATION

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ETM Penultimate Mass

Serial Number	Note 7	Visual inspection	Inspection report included with
			certification
Bond area (surface S3)	Note 6	Interferometry	Surface map of bond surface
			$(\lambda = 633 \text{nm for surface measurements})$
Bond area (surface S4)	Note 4	Interferometry	Surface map of bond surface
			$(\lambda = 633 \text{nm for surface measurements})$

Table 1: Inspection requirements list

Data

To be taken as instructed in Table 1.

Instrumentation used for any given measurement should be listed alongside that measurement.

Orientation

For the purpose of all data collection, data should be taken where possible from side 4 (surface S4). If this is not possible there shall be a special note beside the data indicating from what direction/how it was taken.

Format

All data shall be delivered according to Table 1.